

Search Notes

Application/Control No.

10/628,271

Examiner

John C. Hanley

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2856

SEARCHED

Class	Subclass	Date	Examiner
73	504.02	3/16/2005	JCH
73	504.04	3/16/2005	JCH
73	504.12	3/16/2005	JCH
73	504.13	3/16/2005	JCH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner